Joint ICTP-IAEA Workshop on Modelling for Encapsulated Intermediate Level Waste (ILW) and High Level Waste (HLW) During Long-Term Storage | (smr 3920)

Contribution ID : 49

Type : not specified

Practical use of computer codes "amorph" to simulate X-ray diffraction patterns of practically amorphous materials where irradiation lead to amorphization

Content

Interactive session: Tutorial based modelling exercises in computer facility LBLab (LB)

Summary

Presenter(s) : MAIK LANG (University of Tennessee, USA)

Session Classification : Radiation modelling using SRIM/TRIM codes